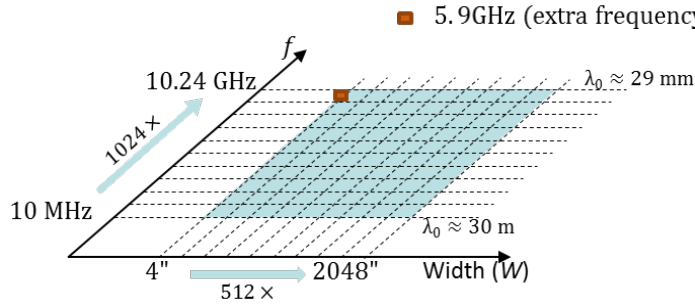


### Description of Scattering Object

A perfect electrically conducting (PEC) plate of size  $W \times 7W/4 \times 31$  mil.

### Length Scale and Frequency Range



The problems of interest cover a range of 512x in physical length scale and 1024x in frequency; the ranges are logarithmically sampled to yield 120 scattering problems. Because the plate is PEC, there are only 20 + 1 unique scattering problems in Problem IIB. In these problems, the sphere sizes are in the range  $0.0034 \leq W/\lambda_0 \leq 1776$ , where  $\lambda_0$  is the free-space wavelength.

### Interesting Features

1. The set includes 1 extra frequency for 1 size because of a publicly available measurement result [1].
2. The thin side wall presents meshing and accurate integration challenges.

### Quantities of Interest

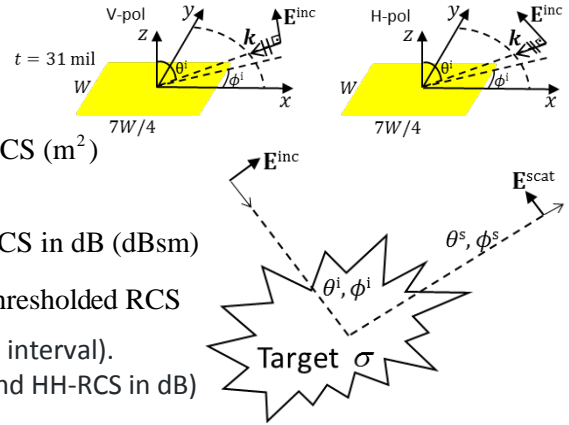
Radar cross section (RCS) definition

$$\sigma_{vu}(\theta^s, \phi^s, \theta^i, \phi^i) = \lim_{R \rightarrow \infty} 4\pi R^2 \frac{|\hat{v}(\theta^s, \phi^s) \cdot \mathbf{E}^{\text{scat}}(\theta^s, \phi^s)|^2}{|\hat{u}(\theta^i, \phi^i) \cdot \mathbf{E}^{\text{inc}}(\theta^i, \phi^i)|^2} : \text{RCS (m}^2\text{)}$$

$$\sigma_{vu,\text{dB}}(\theta^s, \phi^s, \theta^i, \phi^i) = 10 \log_{10} \sigma_{vu} : \text{RCS in dB (dBsm)}$$

$$\sigma_{vu,\text{dB}}^{\text{TH}}(\theta^s, \phi^s, \theta^i, \phi^i) = \max(\sigma_{vu,\text{dB}}, TH_{\text{dB}}) - TH_{vu,\text{dB}} : \text{Thresholded RCS}$$

1. Set  $\theta^i = 80^\circ$ . Vary  $0^\circ \leq \phi^i \leq 90^\circ$  (every  $0.5^\circ$  in the interval).
2. Compute back-scattered  $\sigma_{\theta\theta,\text{dB}}$  and  $\sigma_{\phi\phi,\text{dB}}$  (the VV and HH-RCS in dB) at  $N_\phi = 181$  directions.



### Performance Measures

**Error Measure:** Simulation errors shall be quantified using

$$\text{avg. err}_{uu,\text{dB}}^{\text{TH}} = \frac{1}{2\pi} \int_0^{2\pi} |\sigma_{uu,\text{dB}}^{\text{TH}}(\phi^s) - \sigma_{uu,\text{dB}}^{\text{ref},\text{TH}}(\phi^s)| d\phi^s \approx \frac{1}{N_\phi} \sum_{n=1}^{N_\phi} |\sigma_{uu,\text{dB}}^{\text{TH}}(\phi^s) - \sigma_{uu,\text{dB}}^{\text{ref},\text{TH}}(\phi^s)| \text{ (dB) for } u \in \{\theta, \phi\}$$

where

$$TH_{\text{dB}} = \max_{\phi^s} \sigma_{uu,\text{dB}}^{\text{ref}} - 80 \text{ (dB)}$$

This error measure discounts errors in RCS values below  $TH$ .

**Cost Measure:** Simulation costs shall be quantified using observed wall-clock time and peak memory/core

$$t_{\text{main}}^{\text{wall}} \text{ (s)}$$

$$mem_{\text{main}}^{\text{maxcore}} \text{ (bytes)}$$

as well as the “serialized” CPU time and total memory requirement

$$t_{\text{main}}^{\text{total}} = N_{\text{proc}} \times t_{\text{main}}^{\text{wall}} \text{ (s)}$$

$$mem_{\text{main}}^{\text{max}} = N_{\text{proc}} \times mem_{\text{main}}^{\text{maxcore}} \text{ (bytes)}$$

Here,  $N_{\text{proc}}$  denote the number of processes used in a parallel simulation. It is expected that results will be reported for at least 2 runs: “Efficient” (small  $N_{\text{proc}}$ ) and “Fast” (large  $N_{\text{proc}}$ ).

**Study 1: Error vs. Cost Sweep**

Fix frequency and fix plate dimensions. Simulate many error levels (proxy: mesh densities) for 4 cases:

Case 1:  $f=10$  MHz,  $W=4$  in Case 2:  $f=5.9$  GHz,  $W=4$  in (Measurement Frequency)

Case 3:  $f=10$  MHz,  $W=128$  in Case 4:  $f=320$  MHz,  $W=128$  in

It's recommended to simulate as many error levels (mesh densities) as possible. 3-5 error levels is typical. A typical error-vs.-cost study will consist of  $4 \times 3 \times 5 = 12 \times 20$  simulations.

**Study 2: Frequency Sweep**

Fix plate dimensions and error level (proxy: mesh density). Simulate many frequencies for 4 cases:

Case 1:  $W=4$ in, error level 1 (coarsest mesh) Case 2:  $W=128$ in, error level 1 (coarsest mesh)

Case 3:  $W=4$ in, error level 2 (finer mesh) Case 4:  $W=128$ in, error level 2 (finer mesh)

Frequencies shall be chosen as  $f \in \{10, 20, 40, \dots, 5120, 10240\}$  MHz. It's recommended to simulate as many frequencies as possible. A full frequency-sweep study will consist of  $4 \times 11 = 44$  simulations.

**Study 3: Size Sweep**

Fix frequency and error level (proxy: mesh density). Simulate many sizes for 4 cases:

Case 1:  $f=10$  MHz, error level 1 (coarsest mesh) Case 2:  $f=320$  MHz, error level 1 (coarsest mesh)

Case 3:  $f=10$  MHz, error level 2 (finer mesh) Case 4:  $f=320$  MHz, error level 2 (finer mesh)

Diameters shall be chosen as  $D \in \{4, 8, 16, \dots, 1012, 2048\}$  in. It's recommended to simulate as many sizes as possible. A full size-sweep study will consist of  $4 \times 9 = 36$  simulations.

**Reference Quantities of Interest**

The following RCS data is made available in the benchmark to enable participants to calibrate their simulators:

4 RCS results corresponding to the cases in study 1 found by using ARCHIE-AIM code, a frequency-domain FFT-accelerated integral-equation solver developed at UT Austin [2]-[4].

**References**

- [1] A. C. Woo, H. T. G. Wang, M. J. Schuh, and M. L. Sanders, "EM programmer's notebook-benchmark plate radar targets for the validation of computational electromagnetics programs," in *IEEE Ant. Propag. Mag.*, vol. 34, no. 6, pp. 52-56, Dec 1992.
- [2] M. F. Wu, G. Kaur, and A. E. Yilmaz, "A multiple-grid adaptive integral method for multi-region problems," *IEEE Trans. Antennas Propag.*, vol. 58, no. 5, pp. 1601-1613, May 2010.
- [3] F. Wei and A. E. Yilmaz, "A more scalable and efficient parallelization of the adaptive integral method part I: algorithm," *IEEE Trans. Antennas Propag.*, vol. 62, no.2, pp. 714-726, Feb. 2014.
- [4] J. W. Massey, V. Subramanian, C. Liu, and A. E. Yilmaz, "Analyzing UHF band antennas near humans with a fast integral-equation method," in *Proc. EUCAP*, Apr. 2016.